

## Notice of References Cited

Application/Control No.

O9/887,759

Examiner

Jacques Veillard

Applicant(s)/Patent Under Reexamination KIERNAN ET AL.

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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,725,227	04-2004	Li, Wen-Syan	707/102
	В	US-6,546,381	04-2003	Subramanian et al.	707/2
	С	US-6,324,533	11-2001	Agrawal et al.	707/3
	D	US-5,899,992	05-1999	lyer et al.	707/7
	Е	US-6,711,560	03-2004	Levy et al.	707/1
	F	US-6,721,725	04-2004	Levy et al.	707/2
	G	US-6,745,174	06-2004	Levy et al.	707/2
	I	US-6,438,741	08-2002	Al-omari et al.	707/2
	_	US-6,061,676	05-2000	Srivastava et al.	707/3
	J	US-6,061,488	05-2000	Lhuillier et al.	385/102
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Р					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U	George Kock et al.: Oracle "The complete Reference, third edition; 1995Mcgraw-Hill; versions 7, 7.1, and 7.2, pp 253-266"
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.